

Title (en)
FAST SPECTROSCOPIC ELLIPSOMETER

Title (de)
SCHNELLES SPEKTROSKOPISCHES ELLIPSOMETER

Title (fr)
ELLIPSOMETRE SPECTROSCOPIQUE RAPIDE

Publication
EP 0736171 A1 19961009 (DE)

Application
EP 95905090 A 19941220

Priority
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• EP 9404235 W 19941220

Abstract (en)
[origin: WO9517662A1] A high-speed ellipsometric measuring process for any number and sequence of measuring light wavelengths, suitable especially for the in situ measurement of processes on a substrate surface. A broad-band radiation source (1) and an opto-acoustically tunable filter (4) which can be controlled by a PC (10) are used for fast wavelength selection.

IPC 1-7
G01N 21/21

IPC 8 full level
G01J 3/447 (2006.01); **G01N 21/21** (2006.01)

CPC (source: EP)
G01J 3/447 (2013.01); **G01N 21/211** (2013.01)

Citation (search report)
See references of WO 9517662A1

Designated contracting state (EPC)
DE FR

DOCDB simple family (publication)
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